

Appendix S-4G Out of band emission, Band Edge

Test Information:

Sample No.:	34GQ-2	Test Date:	2025/06/21~2025/08/20
Test Site:	RF	Test Mode:	Transmitting
Tester:	Usain Ou	Test Result:	Pass

Environmental Conditions:

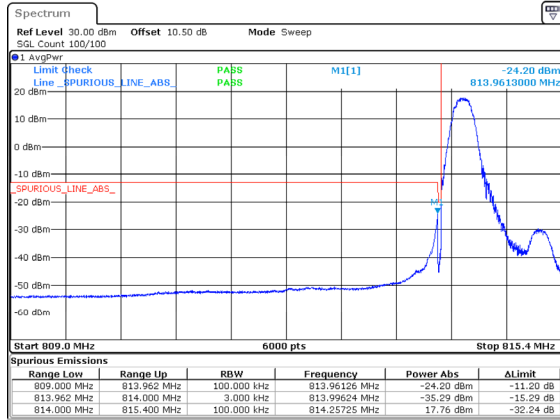
Temperature: (°C)	24.3-25.7	Relative Humidity: (%)	42-58	ATM Pressure: (kPa)	99.8-100.8
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Out of band emission, Band Edge

FCC Part 90S

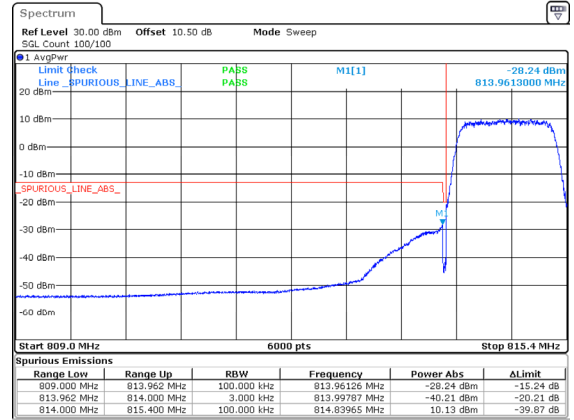
LTE B26_1, Normal

1.4MHz_Low_QPSK_1@0



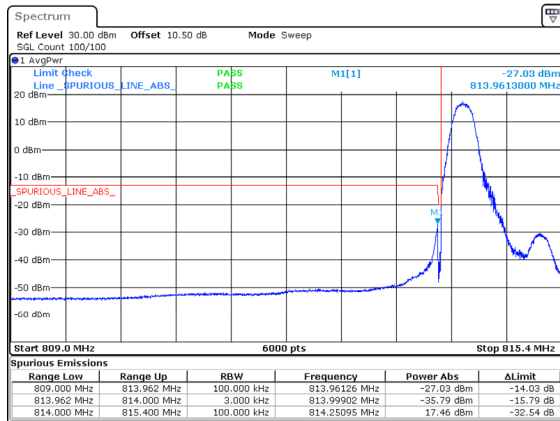
ProjectNo.:2501U64129E-RF Tester:Usain O
Date: 22 JUN 2025 15:08:05

1.4MHz_Low_QPSK_6@0



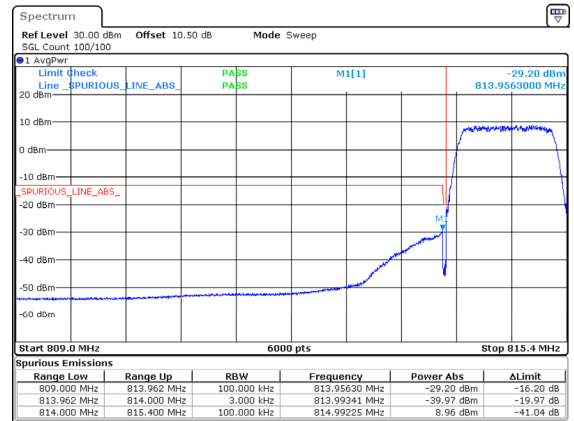
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Date: 22 JUN 2025 15:08:26

1.4MHz_Low_16QAM_1@0



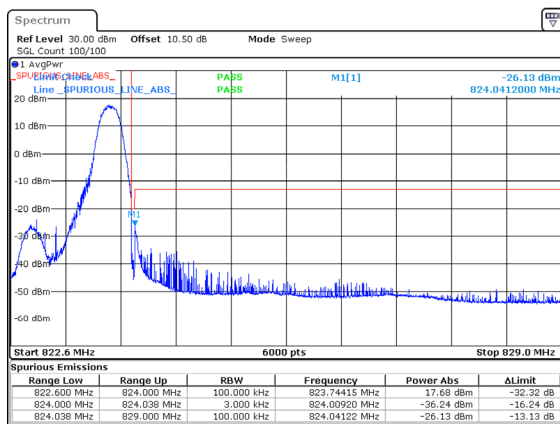
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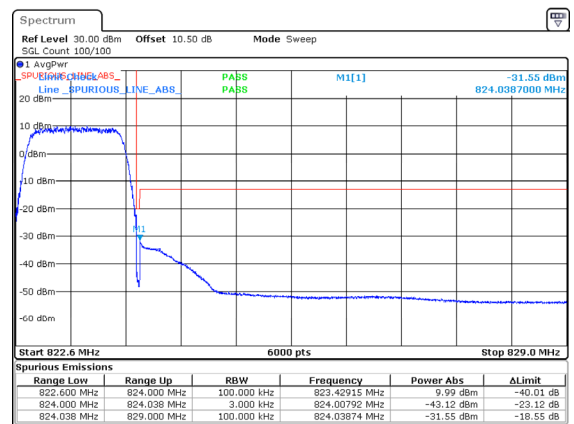
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Date: 22 JUN 2025 15:09:05

1.4MHz_High_QPSK_1@5



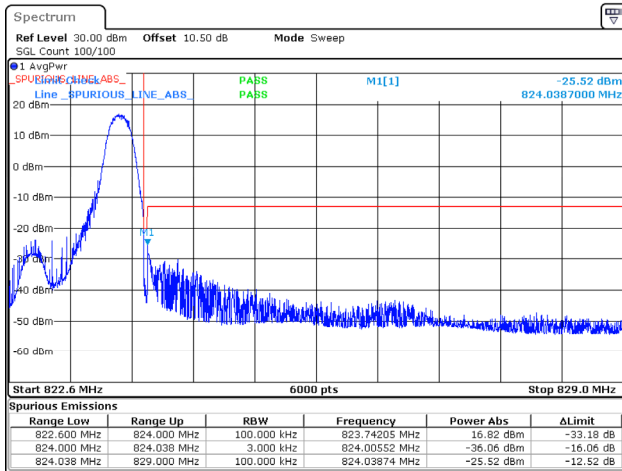
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Date: 22 JUN 2025 15:09:28

1.4MHz_High_QPSK_6@0



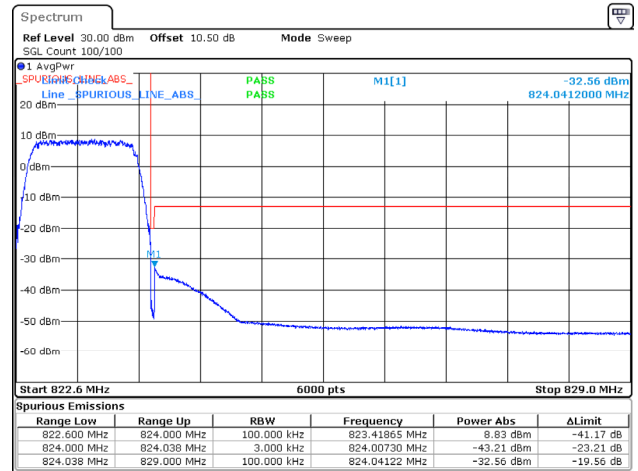
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Date: 22 JUN 2025 15:09:47

1.4MHz_High_16QAM_1@5



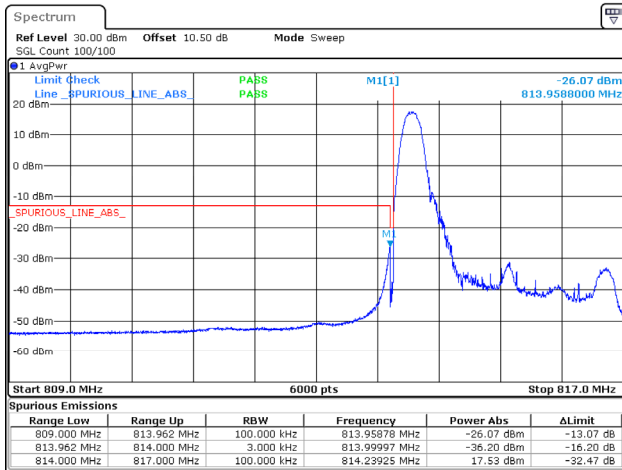
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Date: 22.JUN.2025 15:10:08

1.4MHz_High_16QAM_6@0



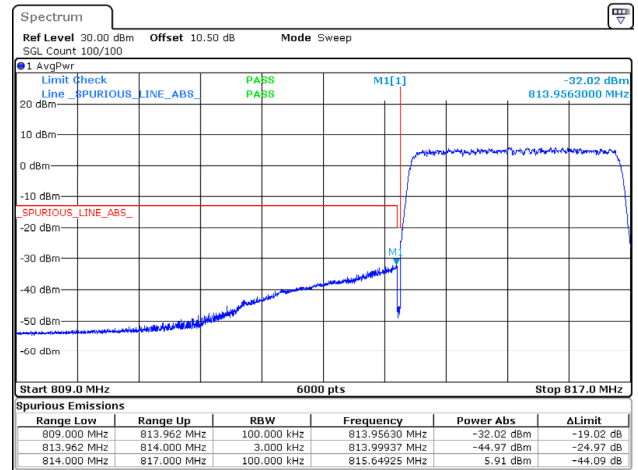
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3MHz_Low_QPSK_1@0



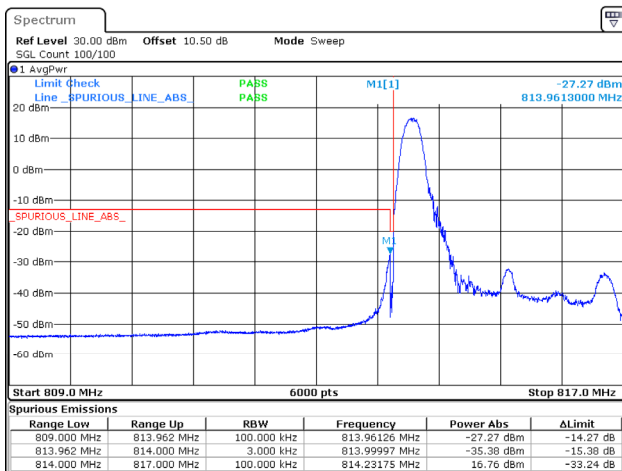
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3MHz_Low_QPSK_15@0



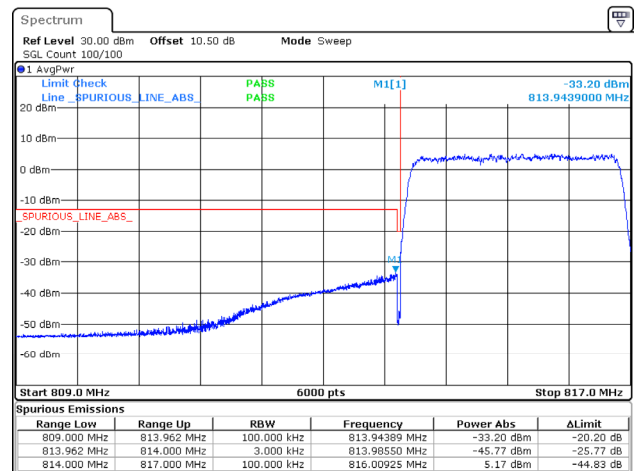
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3MHz_Low_16QAM_1@0



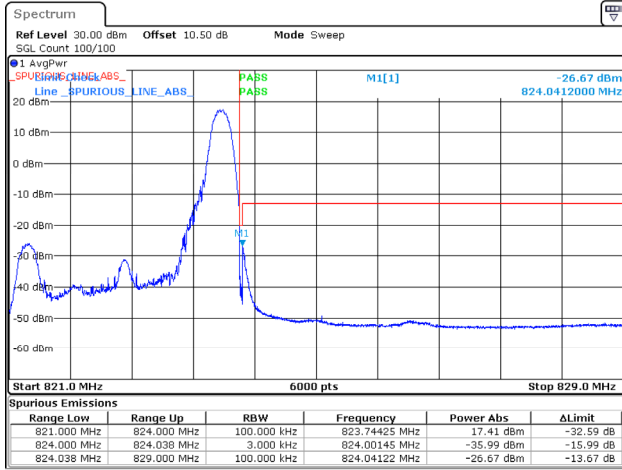
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3MHz_Low_16QAM_15@0



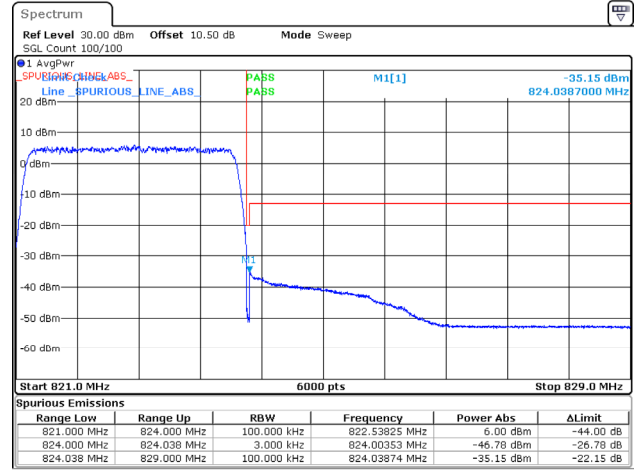
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3MHz_High_QPSK_1@14



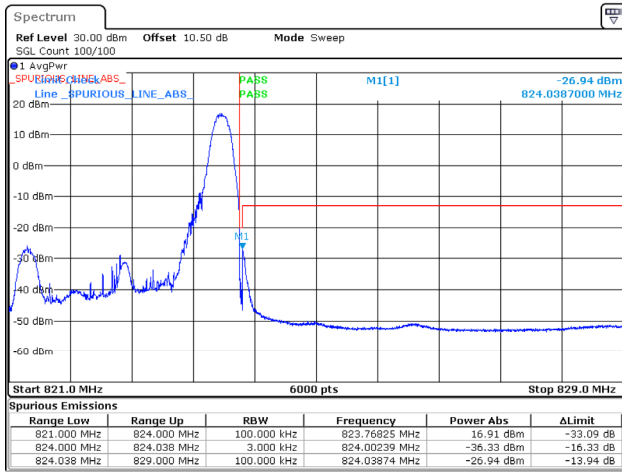
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3MHz_High_QPSK_15@0



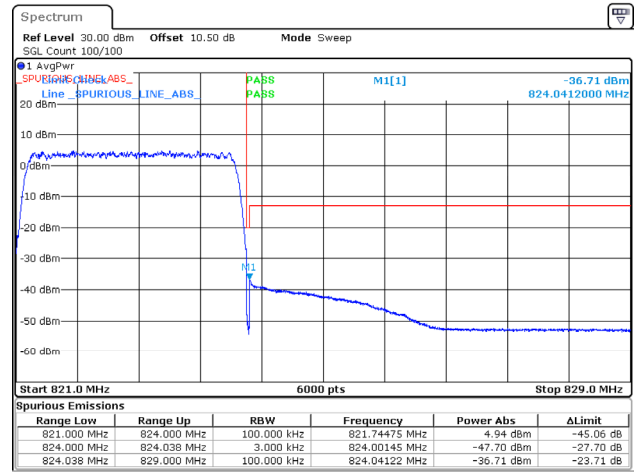
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3MHz_High_16QAM_1@14



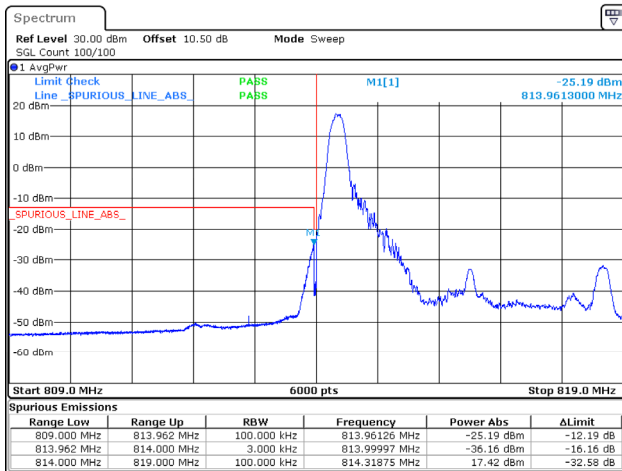
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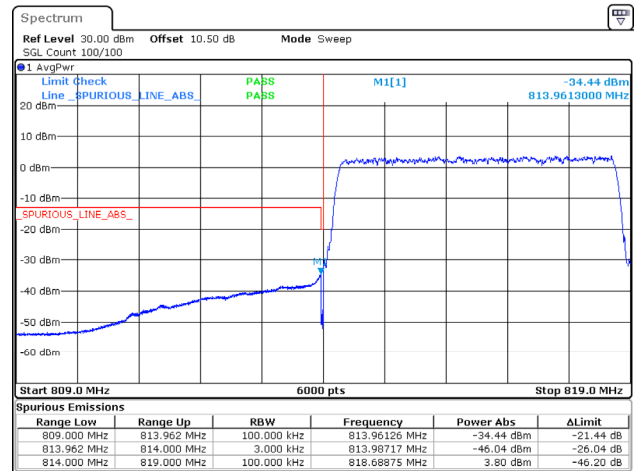
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5MHz_Low_QPSK_1@0



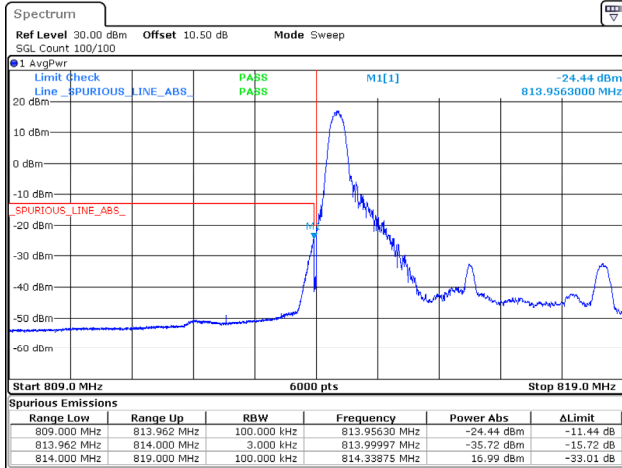
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5MHz_Low_QPSK_25@0



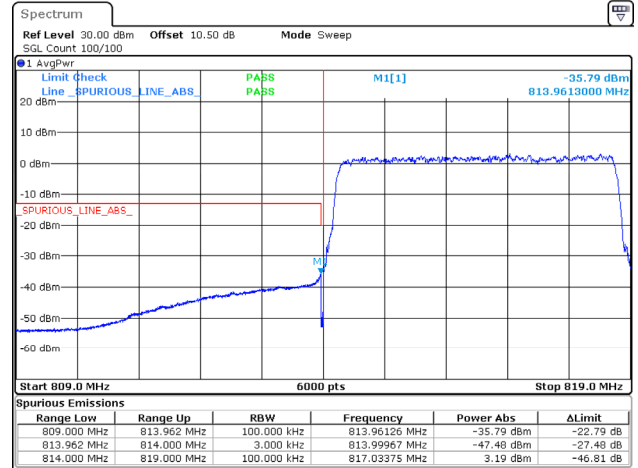
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5MHz_Low_16QAM_1@0



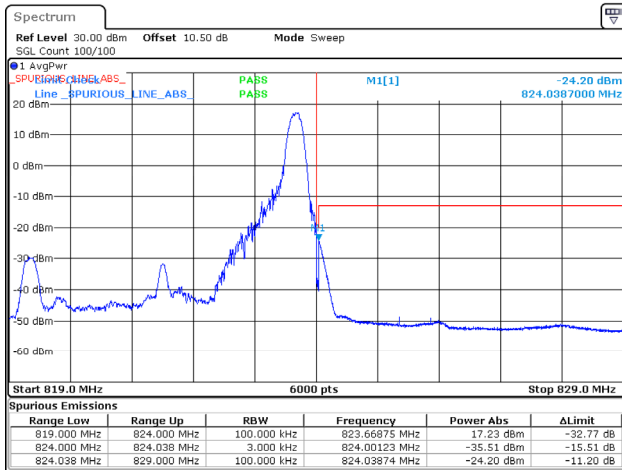
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5MHz_Low_16QAM_25@0



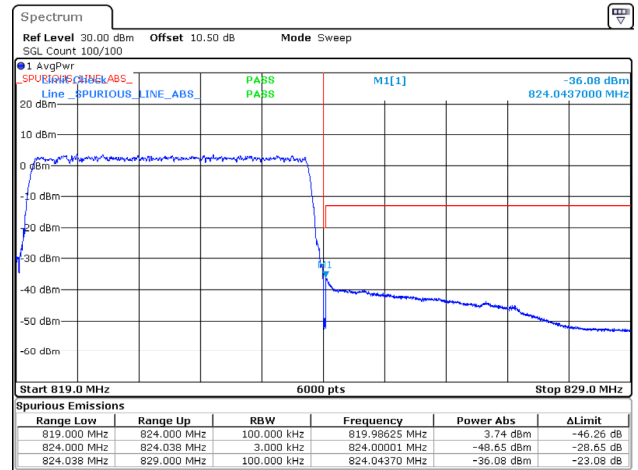
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5MHz_High_QPSK_1@24



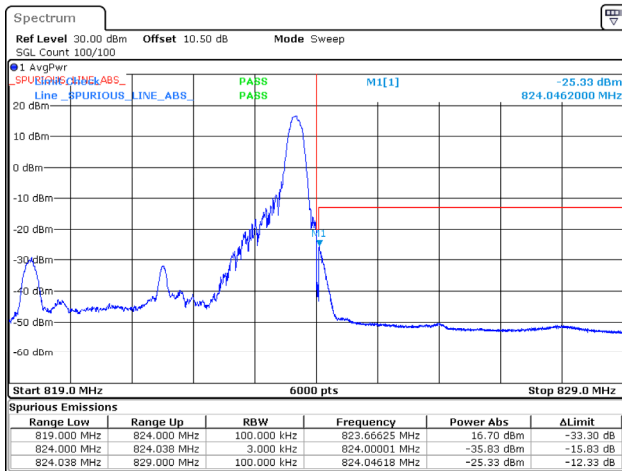
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5MHz_High_QPSK_25@0



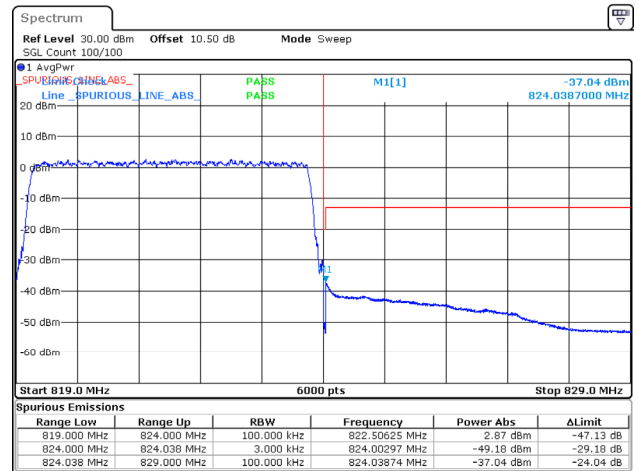
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5MHz_High_16QAM_1@24



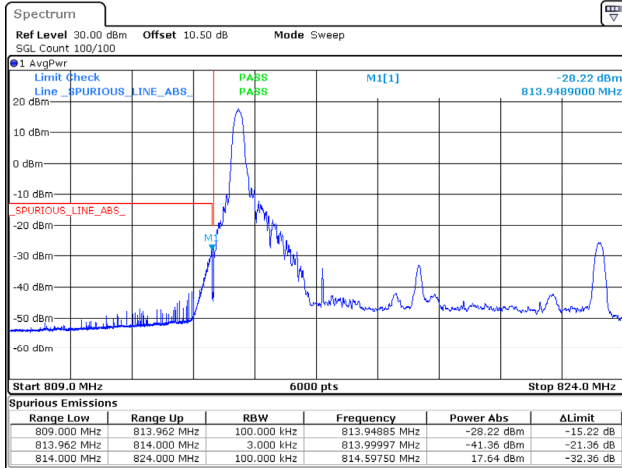
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5MHz_High_16QAM_25@0



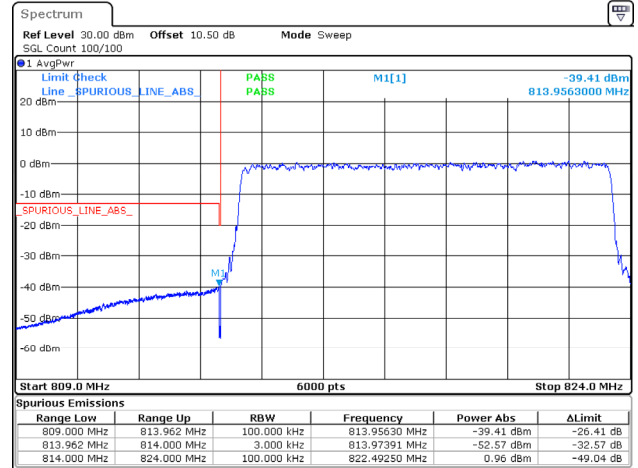
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10MHz_Low_QPSK_1@0



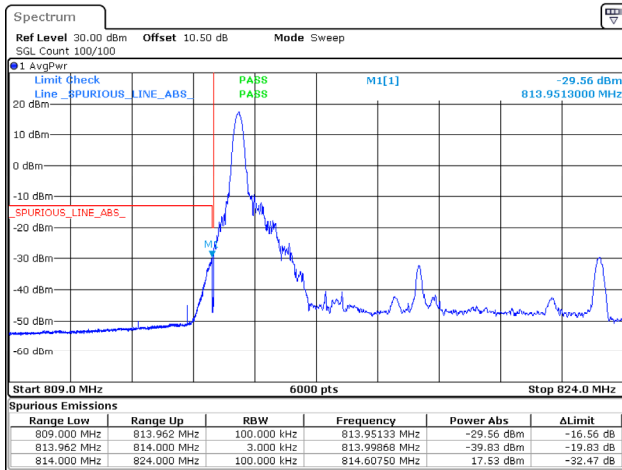
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10MHz_Low_QPSK_50@0



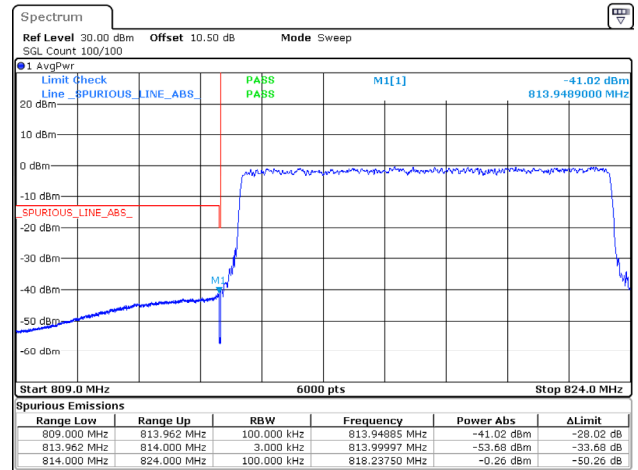
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Date: 22.JUN.2025 15:17:28

10MHz_Low_16QAM_1@0



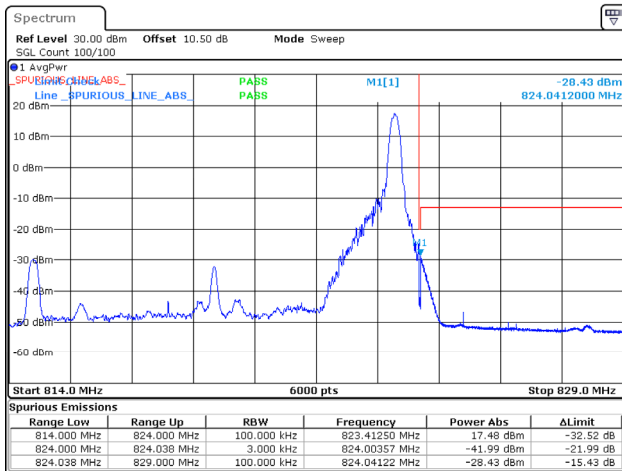
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10MHz_Low_16QAM_50@0



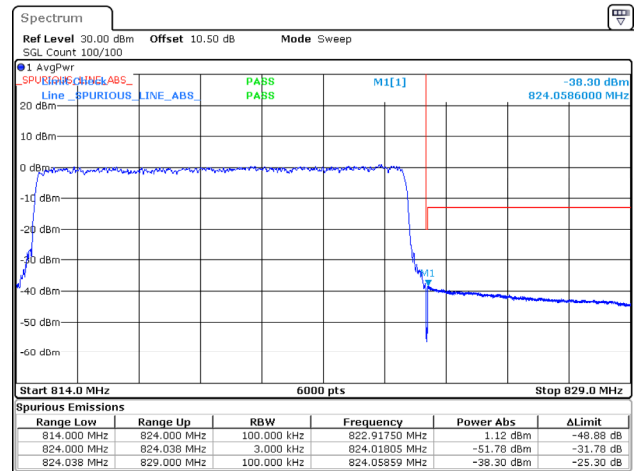
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Date: 22.JUN.2025 15:18:08

10MHz_High_QPSK_1@49



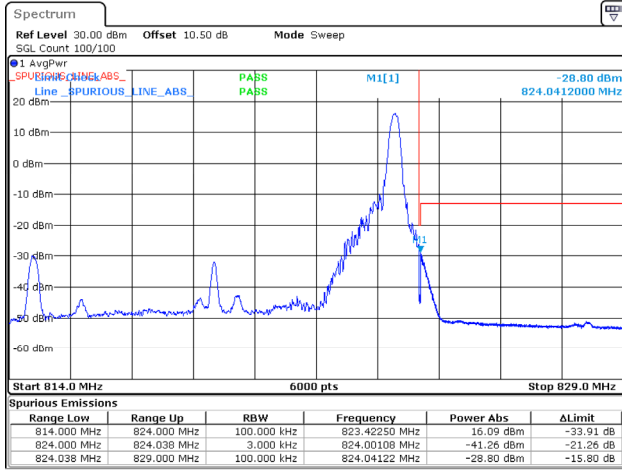
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10MHz_High_QPSK_50@0



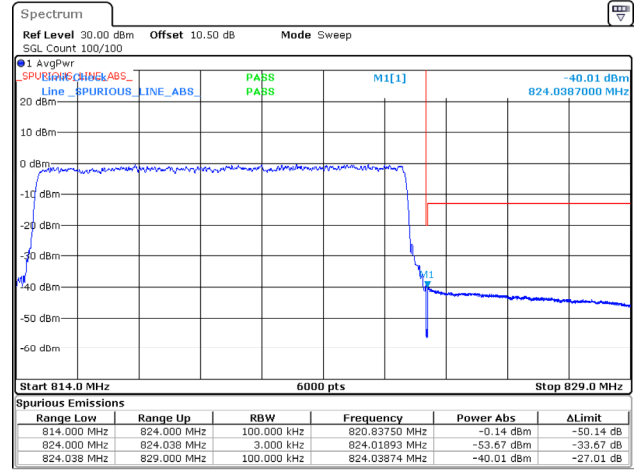
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10MHz_High_16QAM_1@49



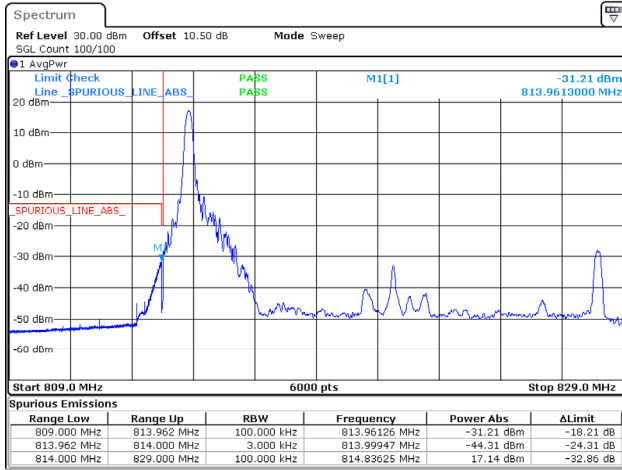
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10MHz_High_16QAM_50@0



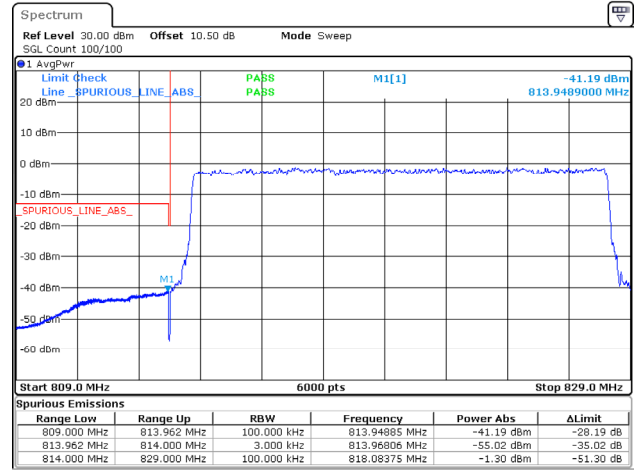
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15MHz_Low_QPSK_1@0



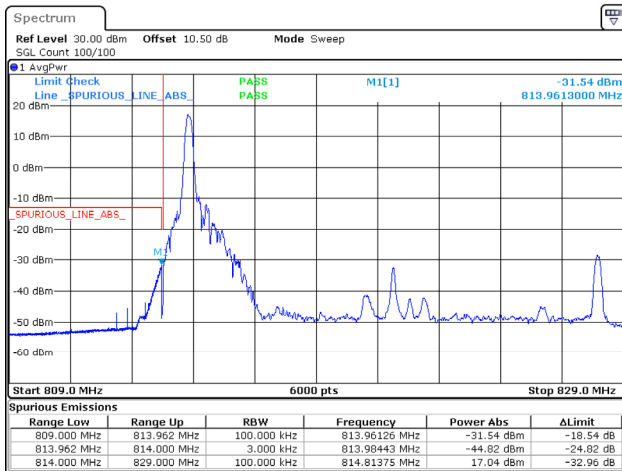
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15MHz_Low_QPSK_75@0



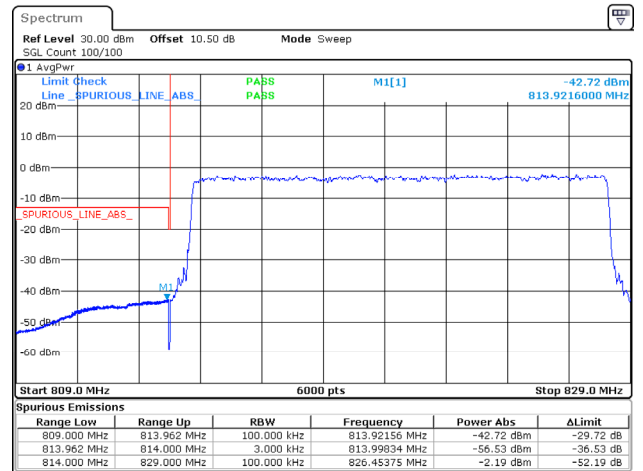
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Date: 22.JUN.2025 15:20:37

15MHz_Low_16QAM_1@0



ProjectNo.:2501U64129E-RF Tester:Usain Ou
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15MHz_Low_16QAM_75@0

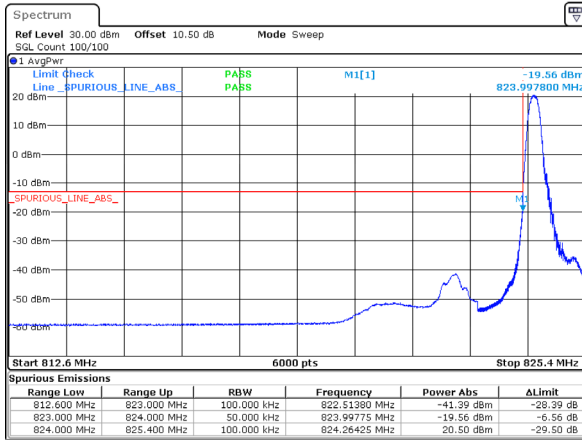


ProjectNo.:2501U64129E-RF Tester:Usain Ou
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FCC Part 22H

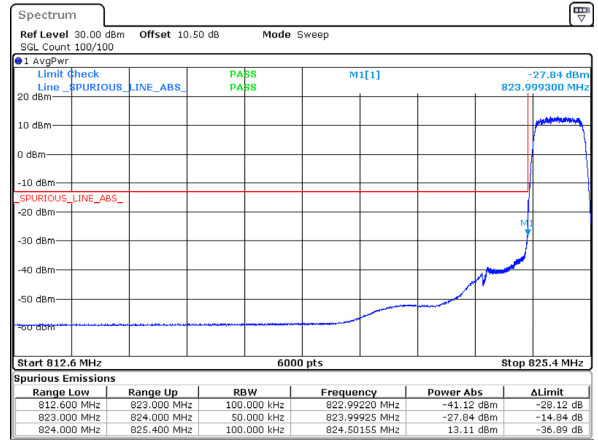
LTE Band 5, Normal

1.4MHz_Low_QPSK_1@0



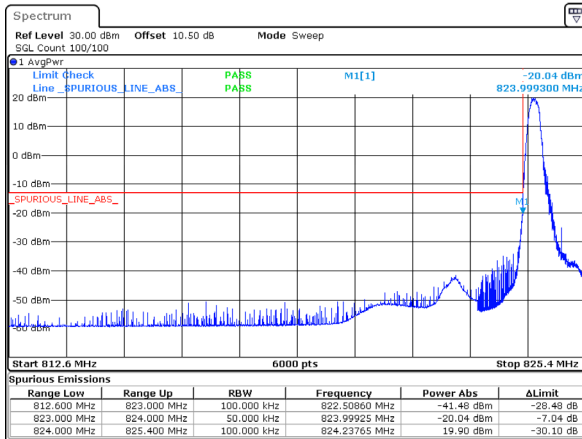
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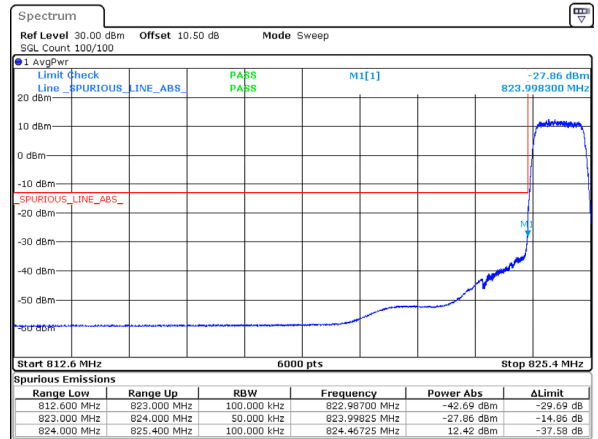
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1.4MHz_Low_16QAM_1@0



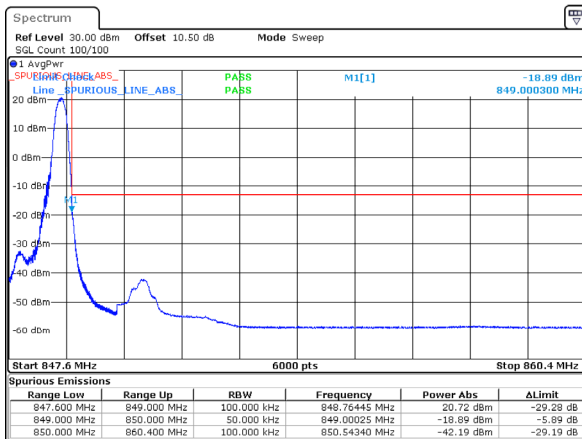
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1.4MHz_Low_16QAM_6@0



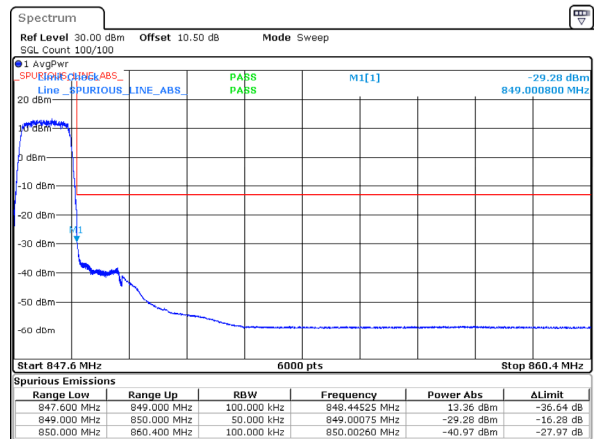
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Date: 22.JUN.2025 13:28:50

1.4MHz_High_QPSK_1@5



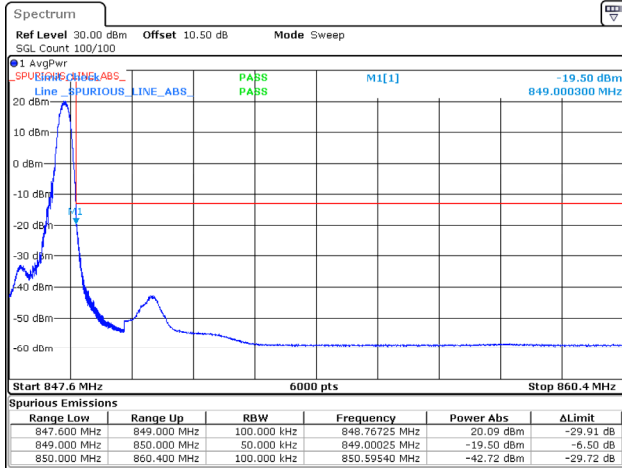
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1.4MHz_High_QPSK_6@0



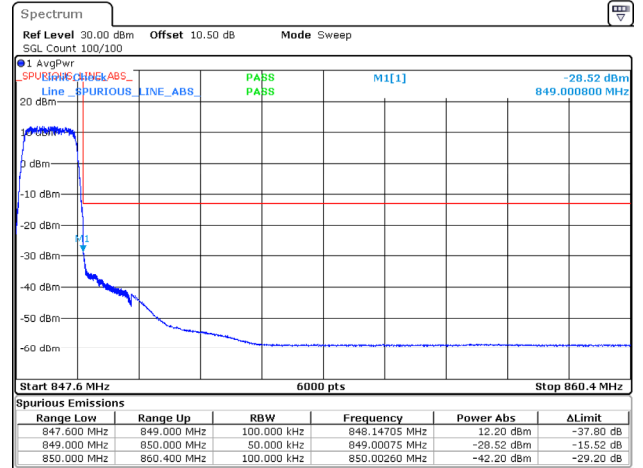
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1.4MHz_High_16QAM_1@0



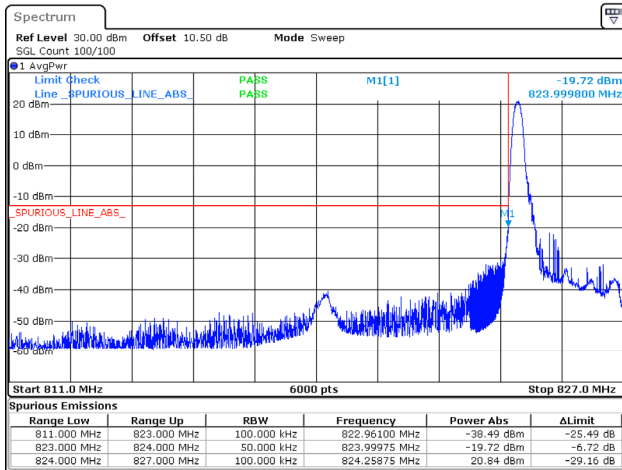
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1.4MHz_High_16QAM_6@0



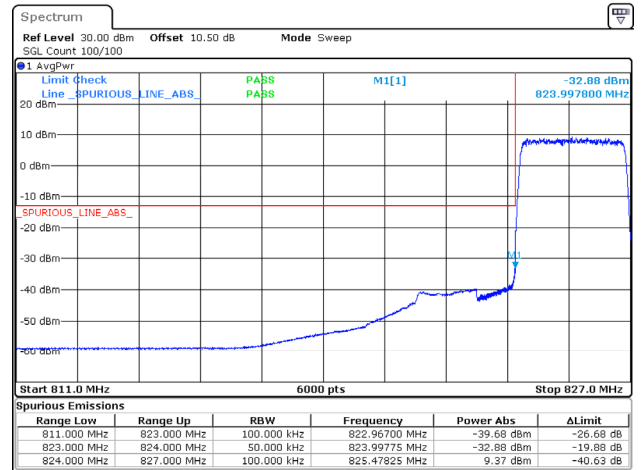
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3MHz_Low_QPSK_1@0



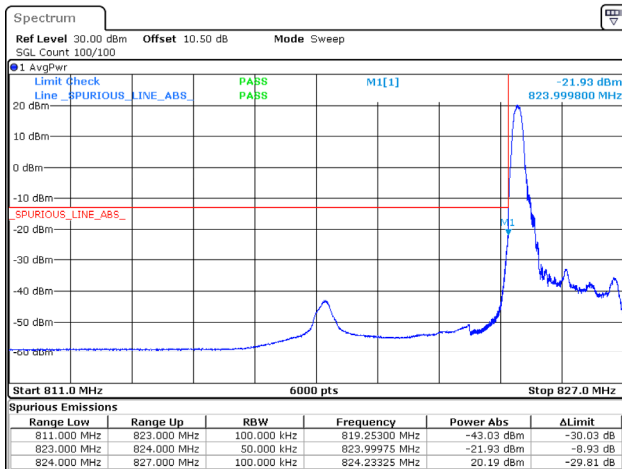
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3MHz_Low_QPSK_15@0



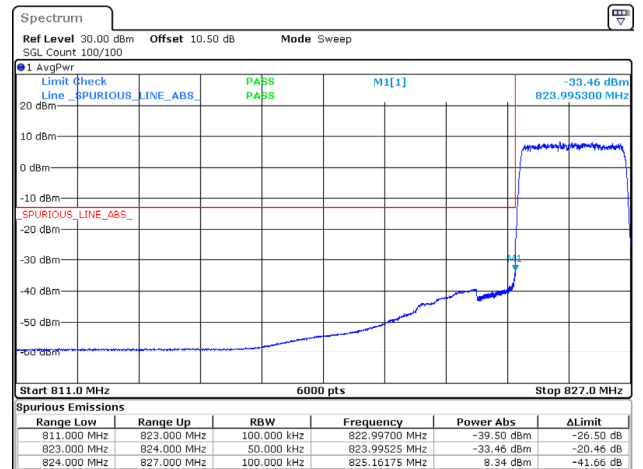
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3MHz_Low_16QAM_1@0



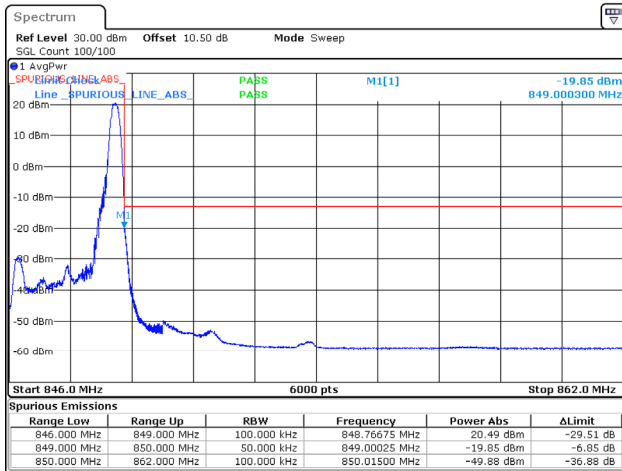
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3MHz_Low_16QAM_15@0



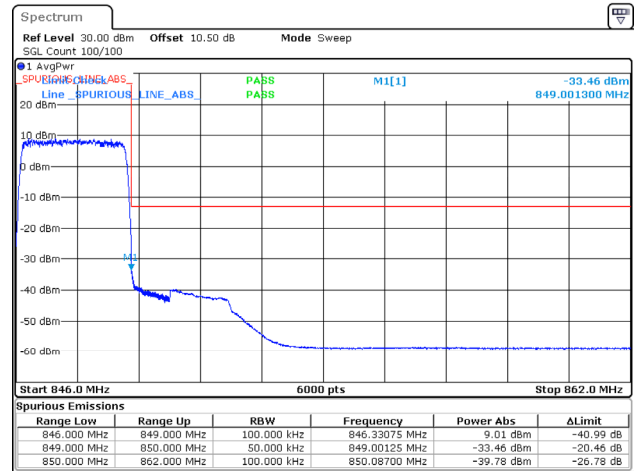
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3MHz_High_QPSK_1@14



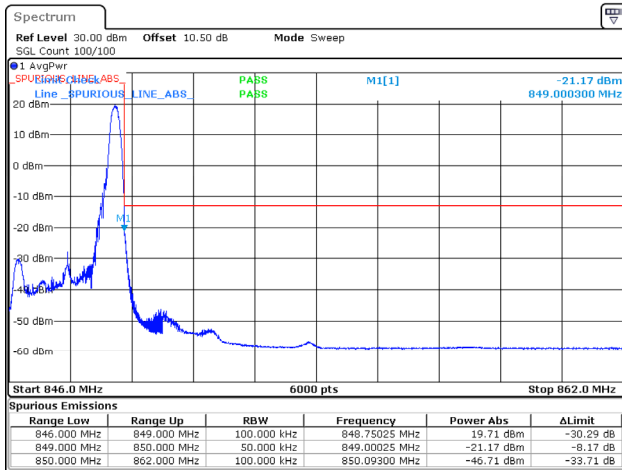
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3MHz_High_QPSK_15@0



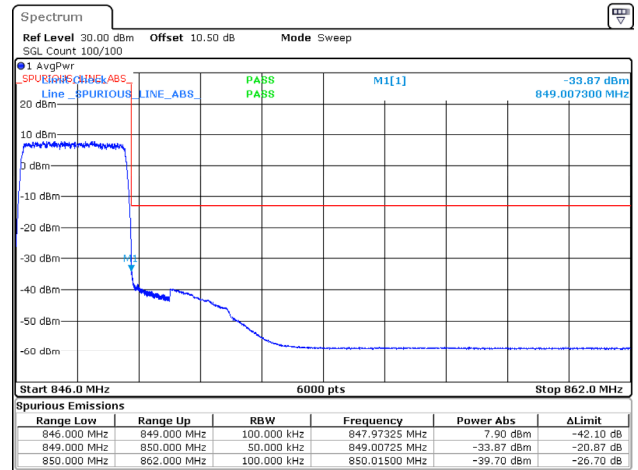
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3MHz_High_16QAM_1@14



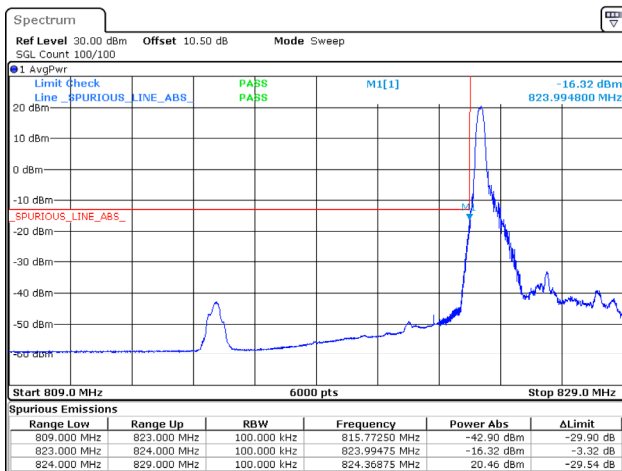
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Date: 22.JUN.2025 13:37:04

3MHz_High_16QAM_15@0



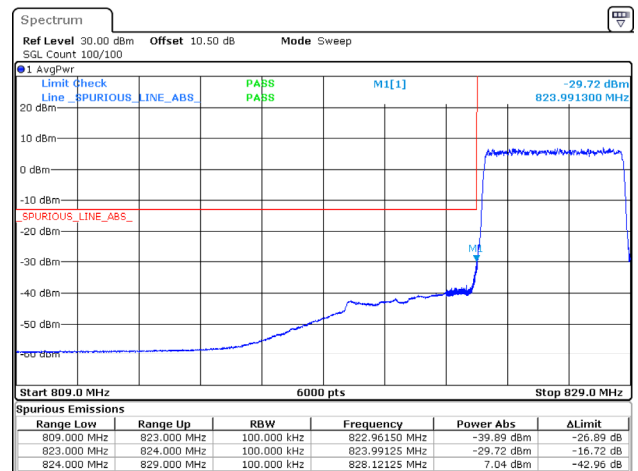
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Date: 22.JUN.2025 13:37:47

5MHz_Low_QPSK_1@0



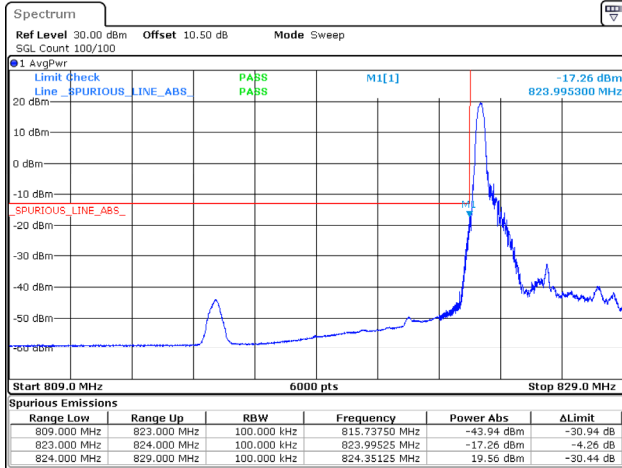
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5MHz_Low_QPSK_25@0



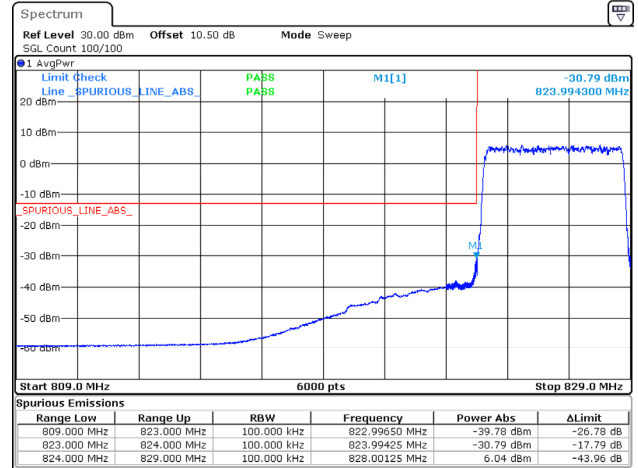
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5MHz_Low_16QAM_1@0



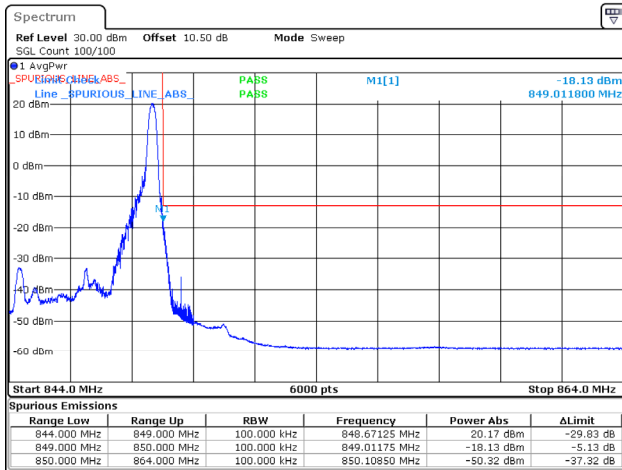
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5MHz_Low_16QAM_25@0



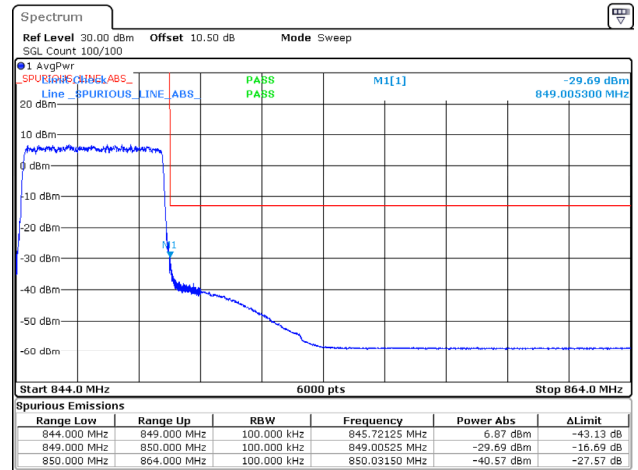
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Date: 22.JUN.2025 13:40:58

5MHz_High_QPSK_1@24



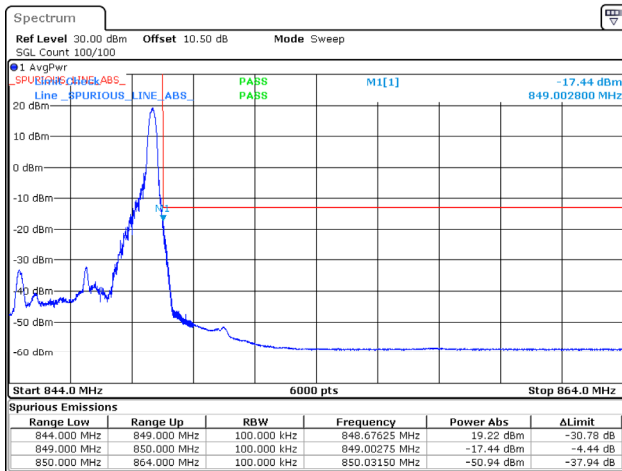
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Date: 22.JUN.2025 13:41:39

5MHz_High_QPSK_25@0



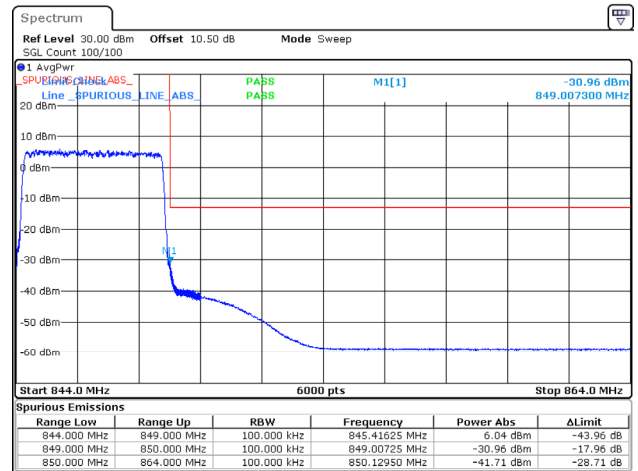
ProjectNo.:2501U64129E-RF Tester:Umain Ou
Date: 22.JUN.2025 13:42:21

5MHz_High_16QAM_1@24



ProjectNo.:2501U64129E-RF Tester:Umain Ou
Date: 22.JUN.2025 13:43:02

5MHz_High_16QAM_25@0



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